Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/723,693	PHUNG ET AL.
Examiner	Art Unit
Tanh Q. Nguyen	2182

	SEARCHED					
Class	Subclass	Date	Examiner			
710	1,5,8,10,20 21,104,305 306,311,312	03/04/06	TQN			
709	203, 220-222					
713	1,2,150	7	4			
			-			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
inventa seaul - eDAN No continuity data IDS review inventa seaul / East Seaul Results attached	05/04/06	TQN		
				